

### General Description

The MDHT4N25 uses advanced Magnachip's MOSFET Technology, which provides low on-state resistance, high switching performance and excellent quality.

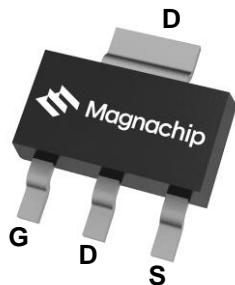
MDHT4N25 is suitable device for SMPS, HID and general purpose applications.

### Features

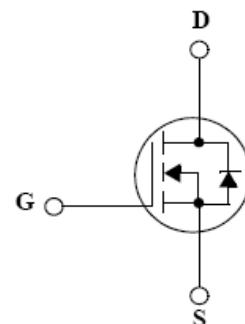
- $V_{DS} = 250V$
- $I_D = 0.83A$
- $R_{DS(ON)} \leq 1.75\Omega$  @ $V_{GS} = 10V$

### Applications

- Power Supply
- PFC
- LED TV



SOT-223



### Absolute Maximum Ratings ( $T_a = 25^\circ C$ )

Characteristics	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DSS}$	250	V
Gate-Source Voltage	$V_{GSS}$	$\pm 30$	V
Continuous Drain Current  $T_c=25^\circ C$	$I_D$	0.83	A
		0.52	A
Pulsed Drain Current <sup>(1)</sup>	$I_{DM}$	3.3	A
Power Dissipation  $T_c=25^\circ C$	$P_D$	2.5	W
		0.02	W/ $^\circ C$
Peak Diode Recovery $dv/dt^{(3)}$	$dv/dt$	5.5	V/ns
Repetitive Pulse Avalanche Energy <sup>(4)</sup>	$E_{AR}$	0.25	mJ
Avalanche current <sup>(1)</sup>	$I_{AR}$	0.83	A
Single Pulse Avalanche Energy <sup>(4)</sup>	$E_{AS}$	52	mJ
Junction and Storage Temperature Range	$T_J, T_{stg}$	-55~150	$^\circ C$

### Thermal Characteristics

Characteristics	Symbol	Rating	Unit
Thermal Resistance, Junction-to-Ambient <sup>(1)</sup>	$R_{\theta JA}$	50	$^\circ C/W$

\*When mounted on the minimum pad size recommended (PCB Mount)

## Ordering Information

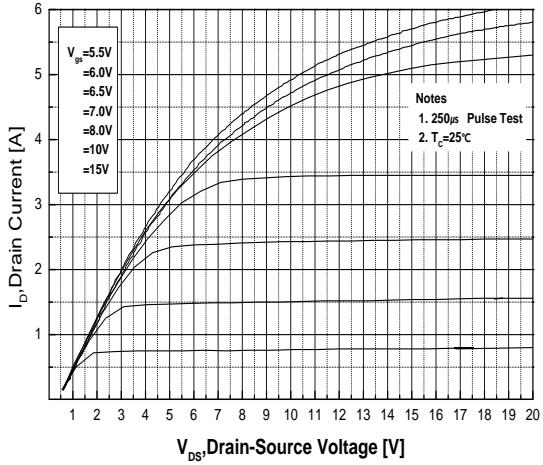
Part Number	Marking	Temp. Range	Package	Packing	RoHS Status
MDHT4N25URH	MDHT4N25	-55~150°C	SOT-223	Reel and Tape	Halogen Free

## Electrical Characteristics ( $T_a = 25^\circ\text{C}$ )

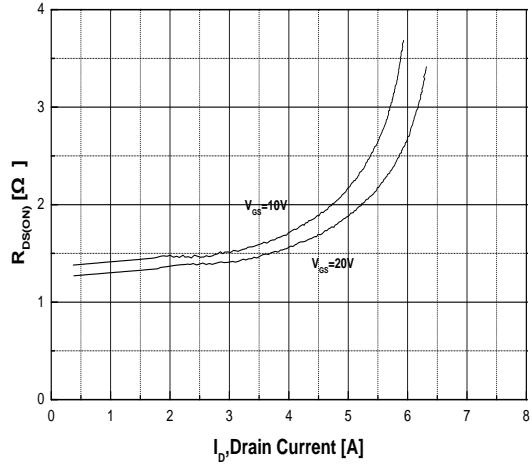
Characteristics	Symbol	Test Condition	Min	Typ	Max	Unit
<b>Static Characteristics</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	250	-	-	V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	3.0	-	5.0	
Drain Cut-Off Current	$I_{DS}$	$V_{DS} = 250\text{V}, V_{GS} = 0\text{V}$	-	-	1	$\mu\text{A}$
Gate Leakage Current	$I_{GSS}$	$V_{GS} = \pm 30\text{V}, V_{DS} = 0\text{V}$	-	-	100	nA
Drain-Source ON Resistance	$R_{DS(\text{ON})}$	$V_{GS} = 10\text{V}, I_D = 0.415\text{A}$		1.38	1.75	$\Omega$
Forward Transconductance	$g_{fs}$	$V_{DS} = 30\text{V}, I_D = 0.415\text{A}$	-	0.91	-	S
<b>Dynamic Characteristics</b>						
Total Gate Charge	$Q_g$	$V_{DS} = 200\text{V}, I_D = 3.6\text{A}, V_{GS} = 10\text{V}$	-	4.2	-	nC
Gate-Source Charge	$Q_{gs}$		-	1.35	-	
Gate-Drain Charge	$Q_{gd}$		-	1.95	-	
Input Capacitance	$C_{iss}$	$V_{DS} = 25\text{V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$	-	146	-	pF
Reverse Transfer Capacitance	$C_{rss}$		-	3	-	
Output Capacitance	$C_{oss}$		-	32	-	
Turn-On Delay Time	$t_{d(on)}$	$V_{GS} = 5\text{V}, V_{DS} = 125\text{V}, I_D = 3.6\text{A}, R_G = 25\Omega$	-	8	-	ns
Rise Time	$t_r$		-	21	-	
Turn-Off Delay Time	$t_{d(off)}$		-	5	-	
Fall Time	$t_f$		-	16	-	
<b>Drain-Source Body Diode Characteristics</b>						
Maximum Continuous Drain to Source Diode Forward Current	$I_S$		-	0.83	-	A
Source-Drain Diode Forward Voltage	$V_{SD}$	$I_S = 0.83\text{A}, V_{GS} = 0\text{V}$	-	-	1.5	V
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F = 3.6\text{A}, dI/dt = 100\text{A}/\mu\text{s}^{(3)}$	-	110	-	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$		-	0.34	-	$\mu\text{C}$

Note :

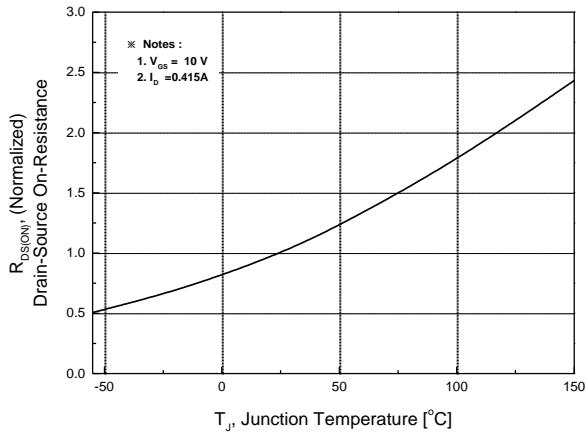
1. Pulse width is based on  $R_{EJC}$  &  $R_{EJA}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ .
2. Pulse test: pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ , pulse width limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{C}$ .
3.  $I_{SD} \leq 3.6\text{A}$ ,  $dI/dt \leq 300\text{A}/\mu\text{s}$ ,  $V_{DD} \leq BV_{DSS}$ ,  $R_g = 25\Omega$ , Starting  $T_J=25^\circ\text{C}$
4.  $L=120\text{mH}$ ,  $I_{AS}=0.83\text{A}$ ,  $V_{DD}=50\text{V}$ ,  $R_g = 25\Omega$ , Starting  $T_J=25^\circ\text{C}$



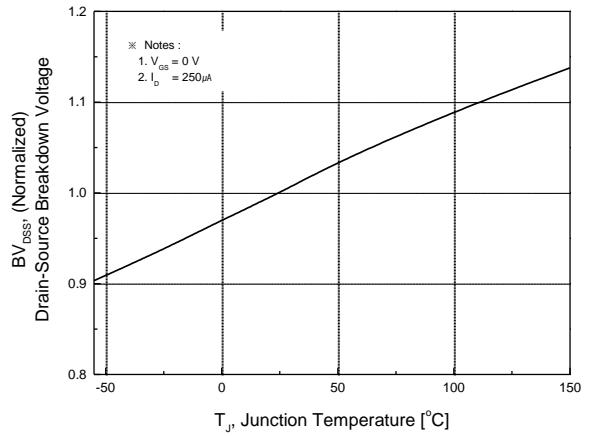
**Fig.1 On-Region Characteristics**



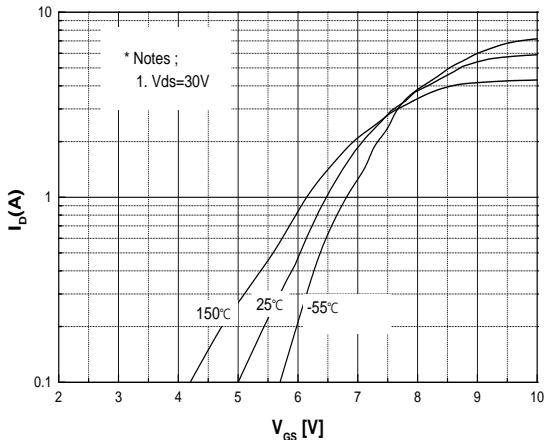
**Fig.2 On-Resistance Variation with Drain Current and Gate Voltage**



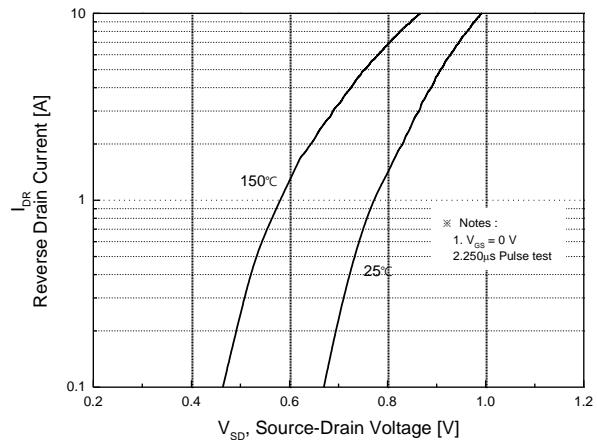
**Fig.3 On-Resistance Variation with Temperature**



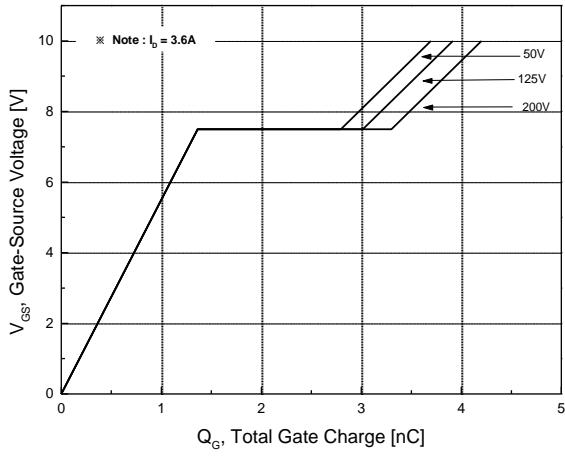
**Fig.4 Breakdown Voltage Variation vs. Temperature**



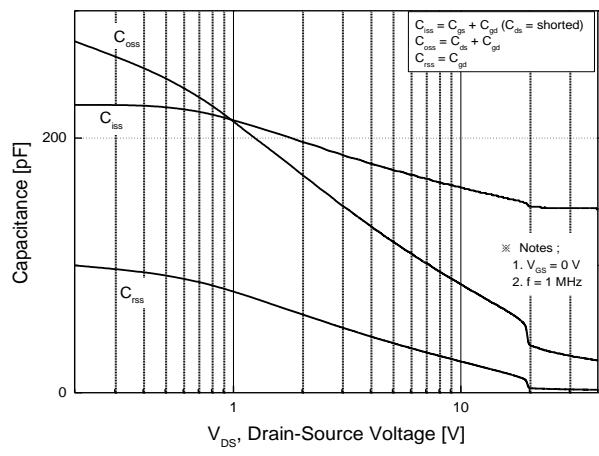
**Fig.5 Transfer Characteristics**



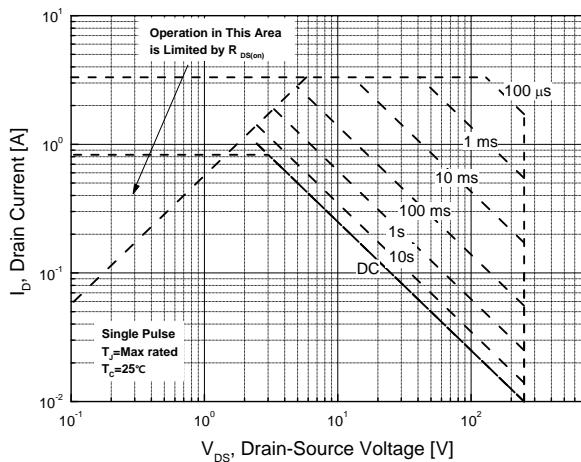
**Fig.6 Body Diode Forward Voltage Variation with Source Current and Temperature**



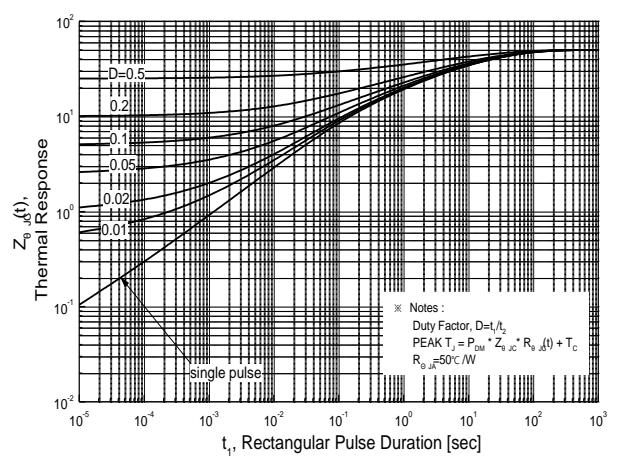
**Fig.7 Gate Charge Characteristics**



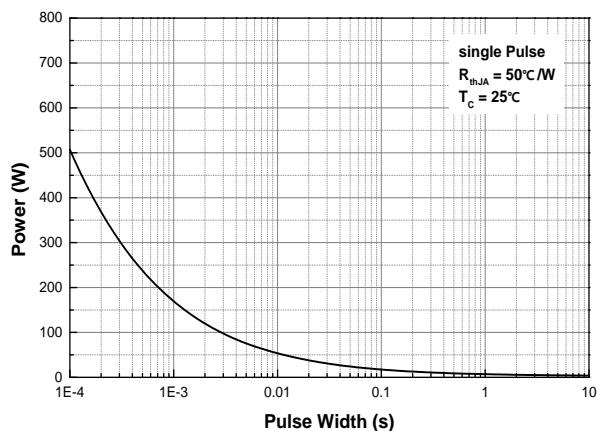
**Fig.8 Capacitance Characteristics**



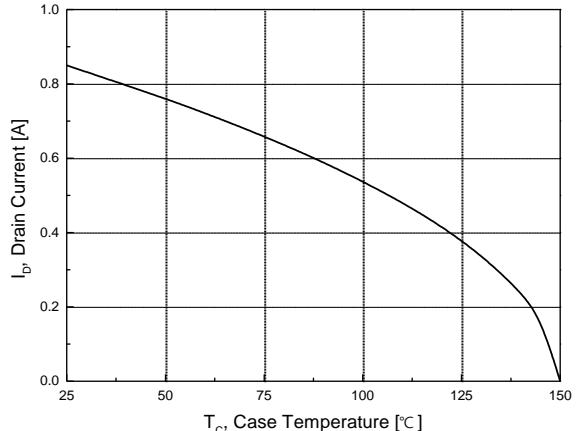
**Fig.9 Maximum Safe Operating Area**



**Fig.10 Transient Thermal Response Curve**



**Fig.11 Single Pulse Maximum Power Dissipation**

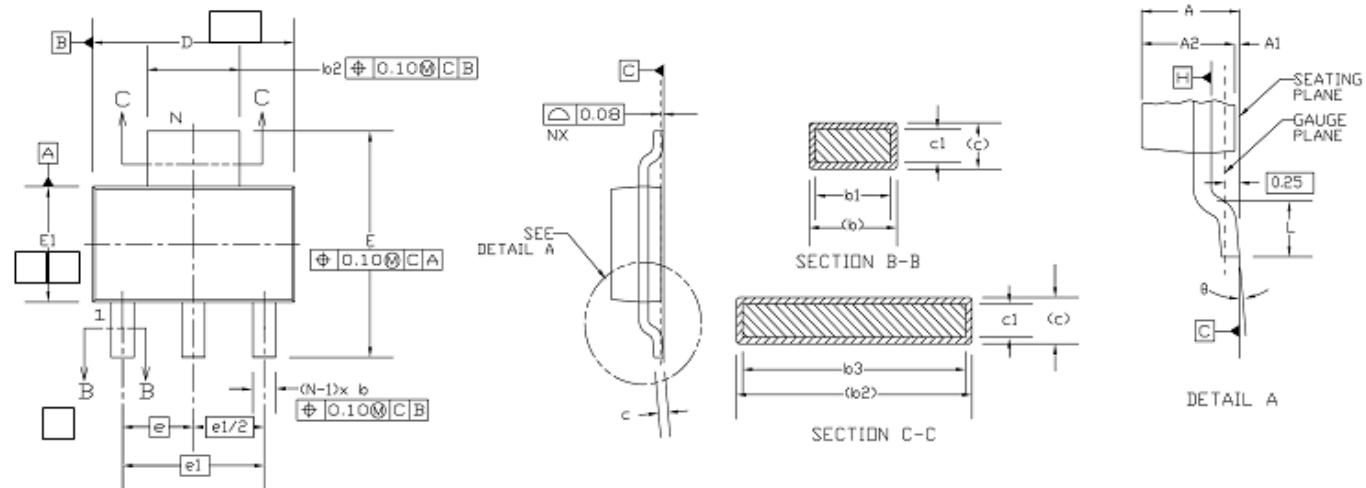


**Fig.12 Maximum Drain Current vs. Case Temperature**

## Physical Dimension

### SOT-223

Dimensions are in millimeters, unless otherwise specified



**DISCLAIMER:**

The Products are not designed for use in hostile environments, including, without limitation, aircraft, nuclear power generation, medical appliances, and devices or systems in which malfunction of any Product can reasonably be expected to result in a personal injury. Seller's customers using or selling Seller's products for use in such applications do so at their own risk and agree to fully defend and indemnify Seller.

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